

FCC/IC - TEST REPORTReport Number : **68.950.17.0844.01** Date of Issue: February 01, 2018Model : SED-WDC-G-5045Product Type : Window/Door SensorApplicant : Viconics Electronics Inc.Address : 9245 Langelier Blvd. Montreal Canada H1P 3K9Production Facility : LEEDARSON LIGHTING CO., LTD.Address : Xingda Road, Xingtai Industrial Zone, Changtai County, 363900: Zhangzhou, Fujian, ChinaTest Result : **n Positive** **o Negative**Total pages including
Appendices : 30

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1 Table of Contents

1	Table of Contents.....	2
2	Details about the Test Laboratory	3
3	Description of the Equipment Under Test	4
4	Summary of Test Standards	5
5	Summary of Test Results	6
6	General Remarks.....	7
7	Test Setups	8
8	Systems test configuration.....	9
9	Technical Requirement.....	10
9.1	Conducted peak output power.....	10
9.2	Power spectral density	13
9.3	6 dB Bandwidth and 99% Occupied Bandwidth.....	16
9.4	Spurious RF conducted emissions.....	19
9.5	Band edge	23
9.6	Spurious radiated emissions for transmitter	25
10	Test Equipment List.....	29
11	System Measurement Uncertainty	30



2 Details about the Test Laboratory

Details about the Test Laboratory

Test Site 1

Company name: TÜV SÜD Certification and Testing (China) Co., Ltd. Shenzhen Branch
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Telephone: 86 755 8828 6998
Fax: 86 755 8828 5299

FCC Registration No.: 514049
IC Registration No.: 10320A -1

3 Description of the Equipment Under Test

Product:	Window/Door Sensor
Model no.:	SED-WDC-G-5045
FCC ID:	V95-EJSP
IC:	7591A-EJSP
Options and accessories:	Nil
Rating:	DC 3.0V(Supplied by CR2450 Battery)
RF Transmission Frequency:	2405MHz-2480MHz
No. of Operated Channel:	16
Modulation:	OQPSK
Antenna Type:	PIFA Antenna
Antenna Gain:	2.4dBi
Description of the EUT:	The Equipment Under Test (EUT) is Window/Door Sensor operated at 2.4GHz

4 Summary of Test Standards

Test Standards	
FCC Part 15 Subpart C 10-1-2016 Edition	PART 15 - RADIO FREQUENCY DEVICES Subpart C - Intentional Radiators
RSS-Gen Issue 4 November 2014	General Requirements and Information for the Certification of Radio Apparatus
RSS-247 Issue 2 February 2017	Digital Transmission Systems (DTSS), Frequency Hopping Systems (FHSS) and License-Exempt Local Area Network (LE-LAN) Devices

All the test methods were according to KDB558074 D01 v04 DTS Measurement Guidance and ANSI C63.10 (2013).

5 Summary of Test Results

Technical Requirements							
FCC Part 15 Subpart C/RSS-247 Issue 2/RSS-Gen Issue 4							
Test Condition			Pages	Test Site	Test Result		
					Pass	Fail	N/A
§15.207	RSS-Gen, 8.8	Conducted emission AC power port	--	--	☐	☐	☒
§15.247 (b) (1)	RSS-247 5.4(d)	Conducted peak output power	10	Site 1	☒	☐	☐
§15.247(a)(1)	RSS-247 5.1(a) & RSS-Gen 6.6	20dB bandwidth	---	---	☐	☐	☒
§15.247(a)(1)	RSS-247 5.1(b)	Carrier frequency separation	---	---	☐	☐	☒
§15.247(a)(1)(iii)	RSS-247 5.1(d)	Number of hopping frequencies	---	---	☐	☐	☒
§15.247(a)(1)(iii)	RSS-247 5.1(d)	Dwell Time	---	---	☐	☐	☒
§15.247(a)(2)	RSS-247 5.2(a)	6dB bandwidth and 99% Occupied Bandwidth	13	Site 1	☒	☐	☐
§15.247(e)	RSS-247 5.2(b)	Power spectral density	16	Site 1	☒	☐	☐
§15.247(d)	RSS-247 5.5	Spurious RF conducted emissions	19	Site 1	☒	☐	☐
§15.247(d)	RSS-247 5.5	Band edge	23	Site 1	☒	☐	☐
§15.247(d) & §15.209	RSS-247 5.5 & RSS-Gen 6.13	Spurious radiated emissions for transmitter	25	Site 1	☒	☐	☐
§15.203	RSS-Gen 8.3	Antenna requirement	See note 1		☒	☐	☐

Note 1: N/A=Not Applicable.

Note 2: The EUT uses a PIFA antenna, which gain is 2.4dBi. In accordance to §15.203, it is considered sufficiently to comply with the provisions of this section.

6 General Remarks

Remarks

This submittal(s) (test report) is intended for FCC ID: V95-EJSP, IC: 7591A- EJSP complies with Section 15.207, 15.209, 15.247 of the FCC Part 15, Subpart C, RSS-247 and RSS-Gen rules.

SUMMARY:

All tests according to the regulations cited on page 5 were

n - Performed

o - **Not** Performed

The Equipment under Test

n - **Fulfills** the general approval requirements.

o - **Does not** fulfill the general approval requirements.

Sample Received Date: December 29, 2017

Testing Start Date: December 29, 2017

Testing End Date: January 13, 2018

- TÜV SÜD Certification and Testing (China) Co., Ltd. Shenzhen Branch -

Reviewed by:



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EMC Section Manager

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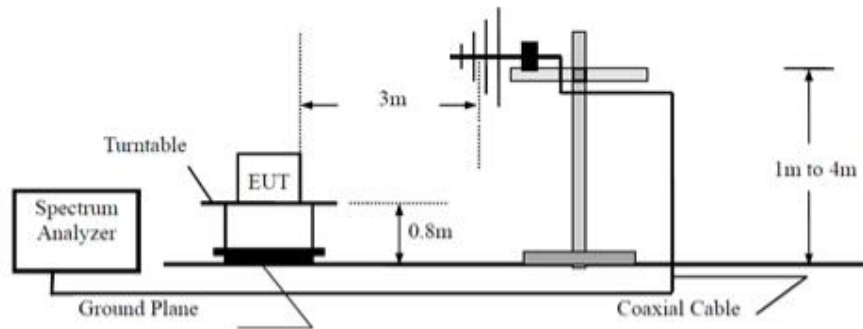
Tested by:



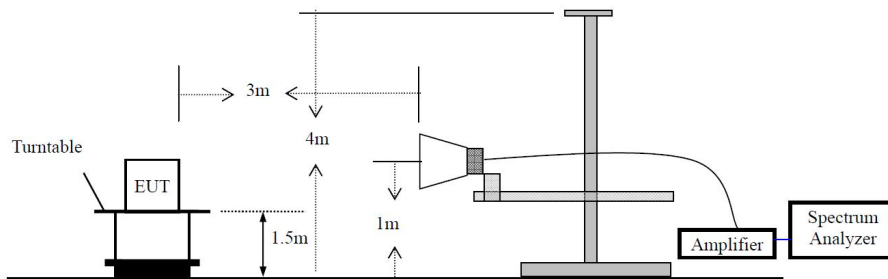
Tree Zhan
EMC Test Engineer

7 Test Setups

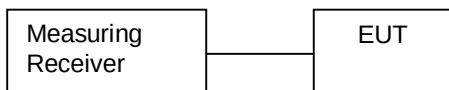
7.1 Below 1GHz



Above 1GHz



7.2 Conducted RF test setups



8 Systems test configuration

Auxiliary Equipment Used during Test:

DESCRIPTION	MANUFACTURER	MODEL NO.(SHIELD)	S/N(LENGTH)
Notebook	Lenovo	X220	---

9 Technical Requirement

9.1 Conducted peak output power

Test Method

1. Use the following spectrum analyzer settings:
RBW > the 6 dB bandwidth of the emission being measured, VBW $\geq$ 3RBW, Span $\geq$ 3RBW
Sweep = auto, Detector function = peak, Trace = max hold.
2. Add a correction factor to the display.
3. Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission. The indicated level is the peak output power.

Limits

According to §15.247 (b) (1), conducted peak output power limit as below:

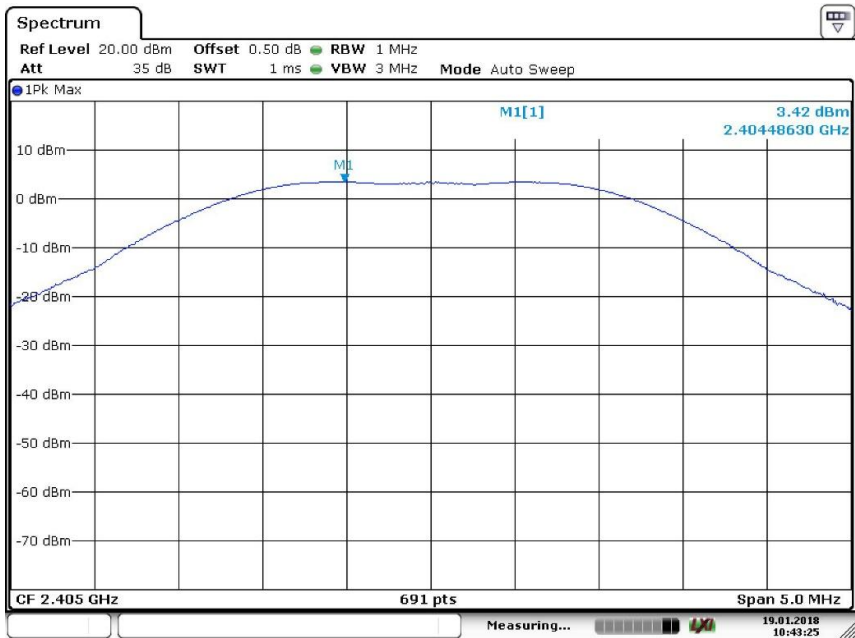
Frequency Range MHz	Limit W	Limit dBm
2400-2483.5	≤ 1	≤ 30

Test result as below table

Frequency MHz	Conducted Peak Output Power dBm	Result
Bottom channel 2405MHz	3.42	Pass
Middle channel 2445MHz	2.70	Pass
Top channel 2480MHz	2.03	Pass

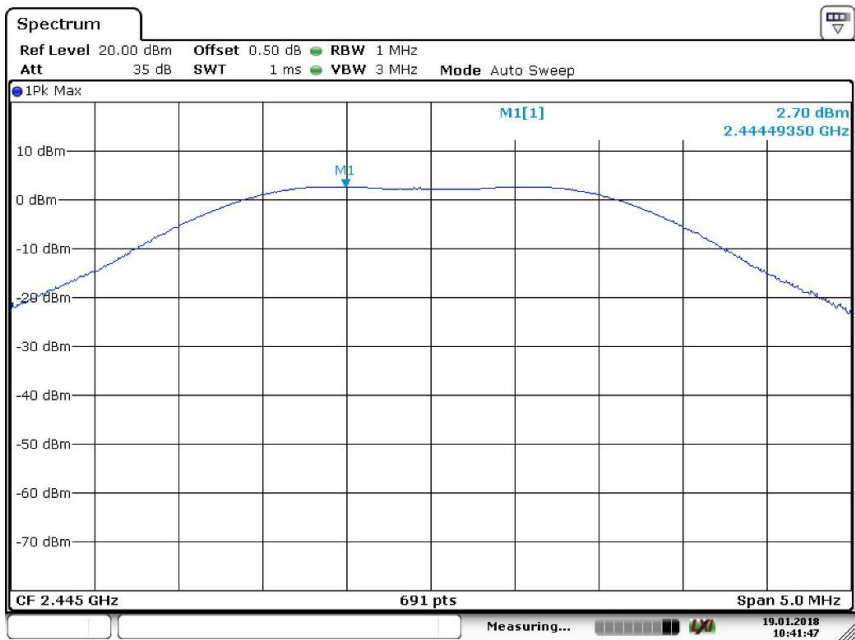


Low channel 2405MHz



Date: 19.JAN.2018 10:43:25

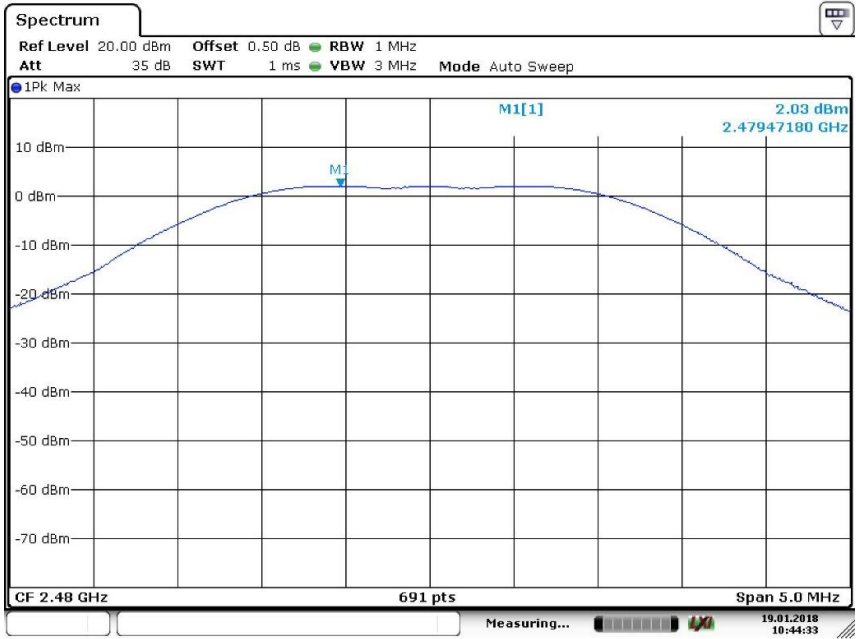
Middle channel 2445MHz



Date: 19.JAN.2018 10:41:47



High channel 2480MHz



Date: 19.JAN.2018 10:44:34

9.2 Power spectral density

Test Method

This procedure shall be used if maximum peak conducted output power was used to demonstrate compliance:

1. Set analyzer center frequency to DTS channel center frequency. RBW=3kHz, VBW $\geq$ 3RBW, Span=1.5 times DTS bandwidth, Detector=Peak, Sweep=auto, Trace= max hold.
2. Allow trace to fully stabilize, use the peak marker function to determine the maximum amplitude level within the RBW.
3. Repeat above procedures until other frequencies measured were completed.

Limit

Limit [dBm]

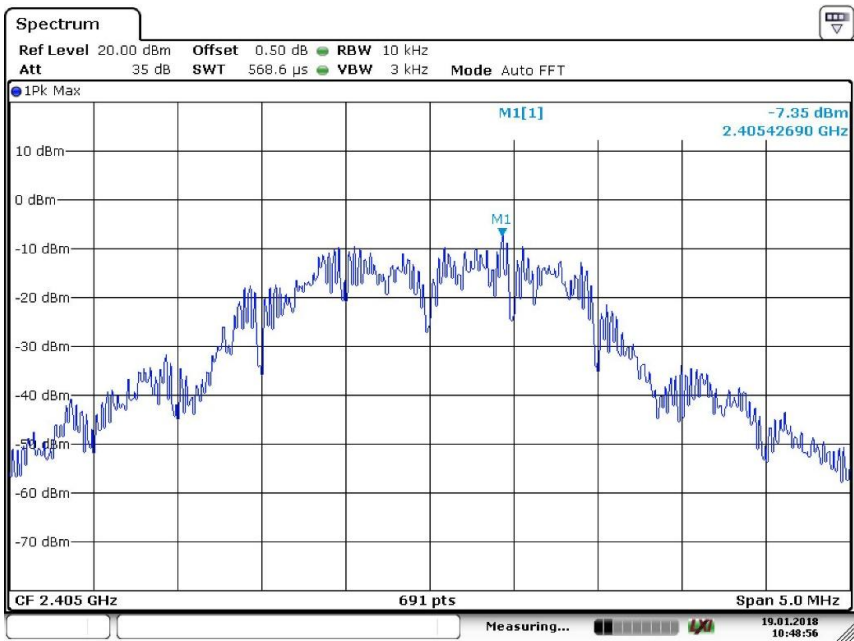
≤ 8

Test result

Frequency MHz	Power spectral density dBm	Result
Top channel 2405MHz	-7.35	Pass
Middle channel 2445MHz	-8.12	Pass
Bottom channel 2480MHz	-8.73	Pass

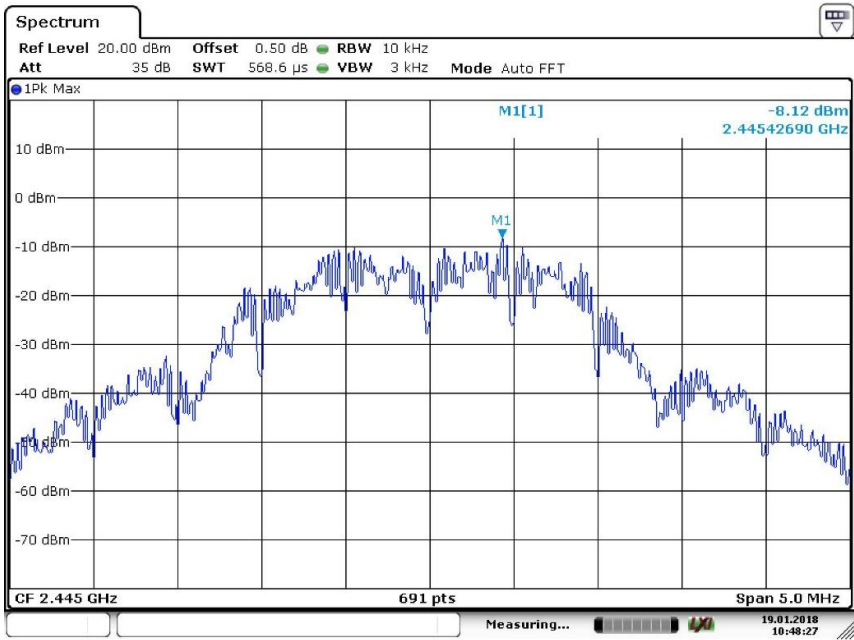


Low channel 2405MHz



Date: 19.JAN.2018 10:48:56

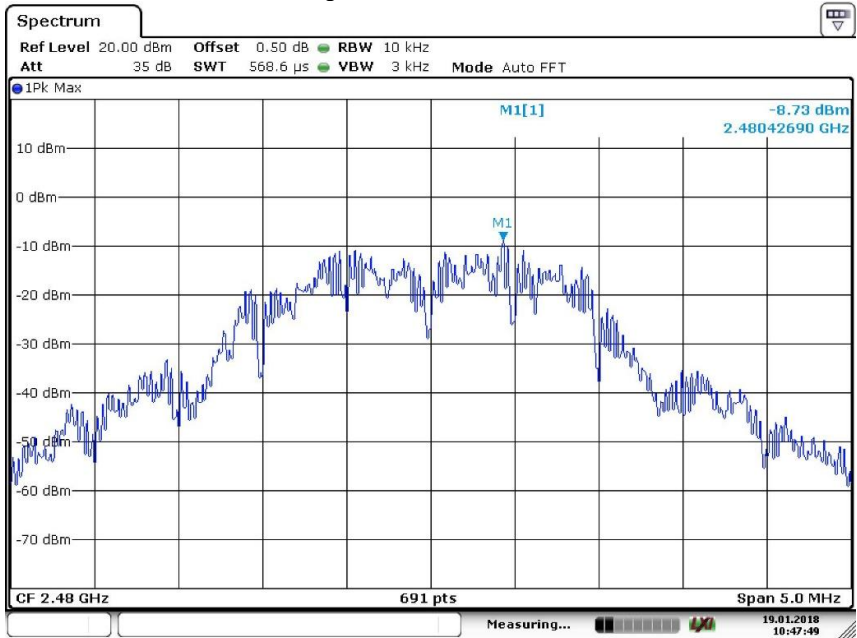
Middle channel 2445MHz



Date: 19.JAN.2018 10:48:27



High channel 2480MHz



Date: 19 JAN 2018 10:47:49

9.3 6 dB Bandwidth and 99% Occupied Bandwidth

Test Method

1. Use the following spectrum analyzer settings:
RBW=100K, VBW $\geq$ 3RBW, Sweep = auto, Detector function = peak, Trace = max hold
2. Use the automatic bandwidth measurement capability of an instrument, may be employed using the X dB bandwidth mode with X set to 6 dB, care shall be taken so that the bandwidth measurement is not influenced by any intermediate power nulls in the fundamental emission that might be $\geq$ 6 dB.
3. Allow the trace to stabilize, record the X dB Bandwidth value.

Limit

Limit [kHz]

≥ 500

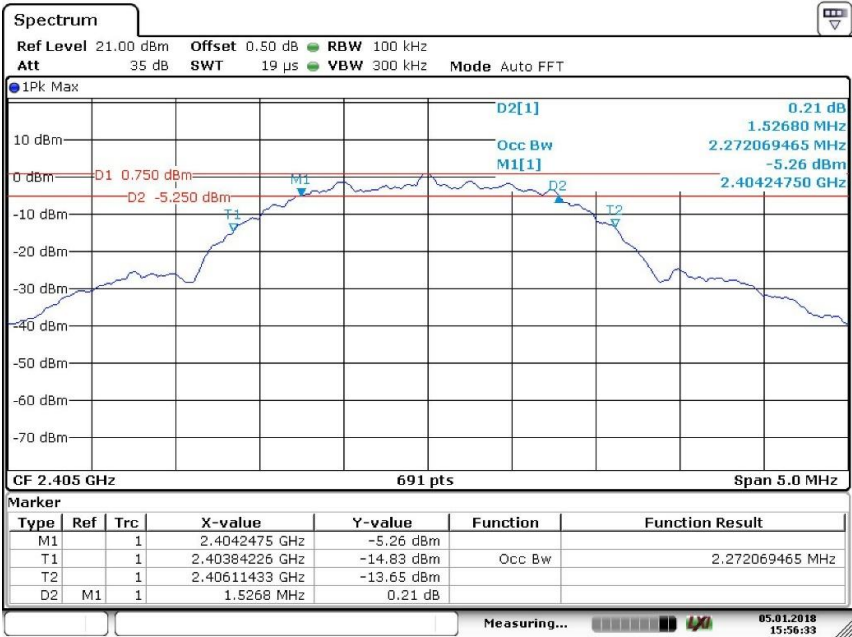
Test result

Frequency MHz	6dB bandwidth kHz	99 bandwidth kHz	Result
Bottom channel 2405MHz	1526.8	2272.1	Pass
Middle channel 2445MHz	1534.0	2257.6	Pass
Top channel 2480MHz	1555.7	2257.6	Pass



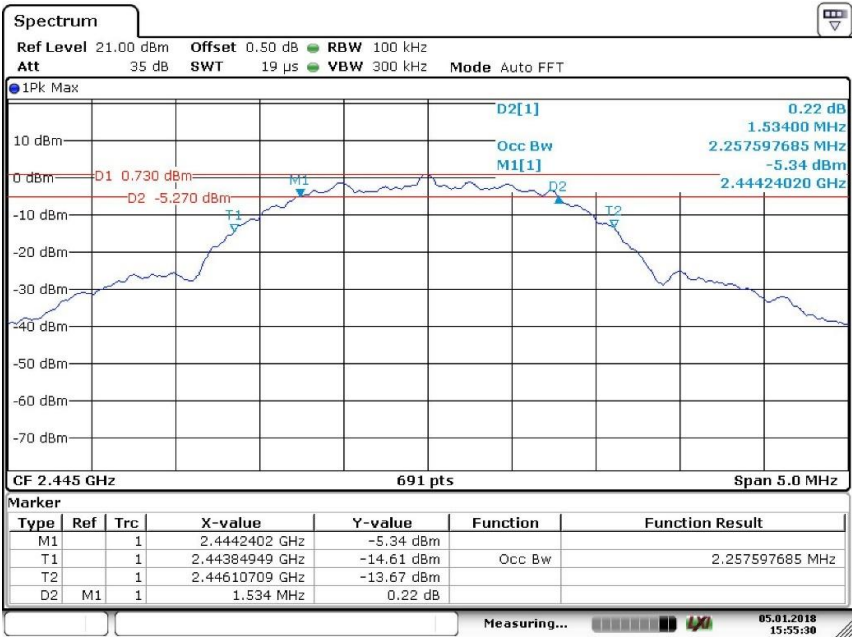
6 dB Bandwidth

Low channel 2405MHz



Date: 5.JAN.2018 15:56:33

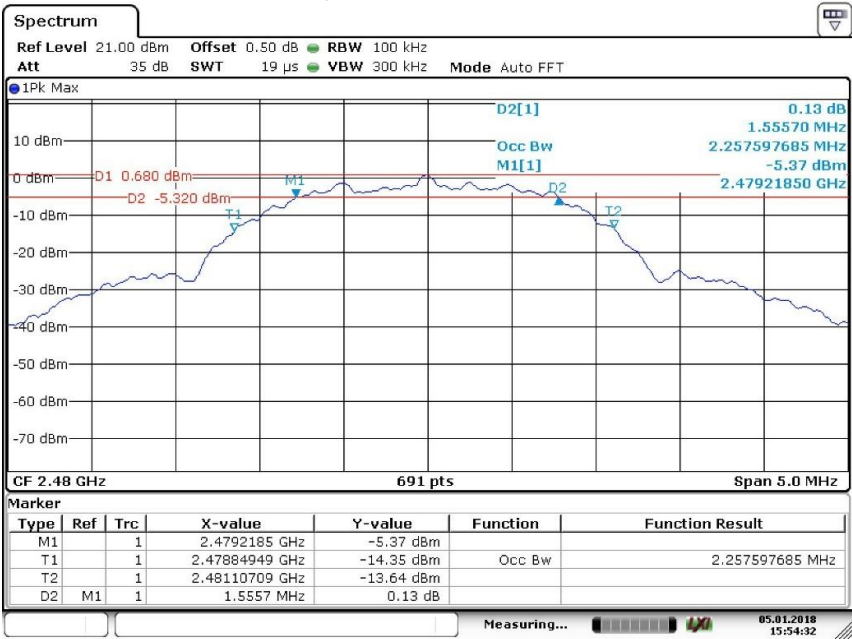
Middle channel 2445MHz



Date: 5.JAN.2018 15:55:30



High channel 2480MHz



Date: 5 JAN 2018 15:54:32

9.4 Spurious RF conducted emissions

Test Method

1. Establish a reference level by using the following procedure:
 - a. Set RBW=100 kHz. VBW $\geq$ 3RBW. Detector =peak, Sweep time = auto couple, Trace mode = max hold.
 - b. Allow trace to fully stabilize, use the peak marker function to determine the maximum PSD level.
2. Use the maximum PSD level to establish the reference level.
 - a. Set the center frequency and span to encompass frequency range to be measured.
 - b. Use the peak marker function to determine the maximum amplitude level. Ensure that the amplitude of all unwanted emissions outside of the authorized frequency band (excluding restricted frequency bands) are attenuated by at least the minimum requirements, report the three highest emissions relative to the limit.
3. Repeat above procedures until other frequencies measured were completed.

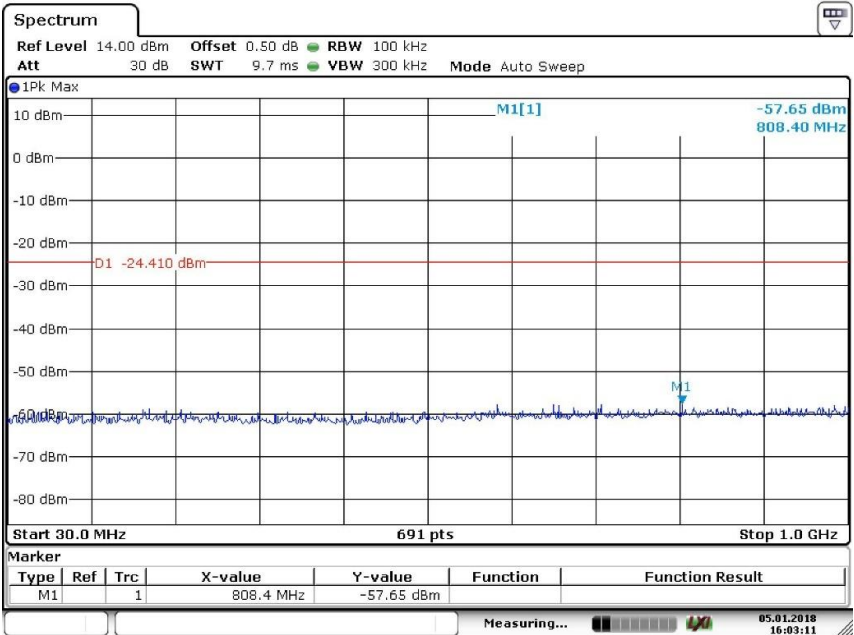
Limit

Frequency Range MHz	Limit (dBc)
30-25000	-20

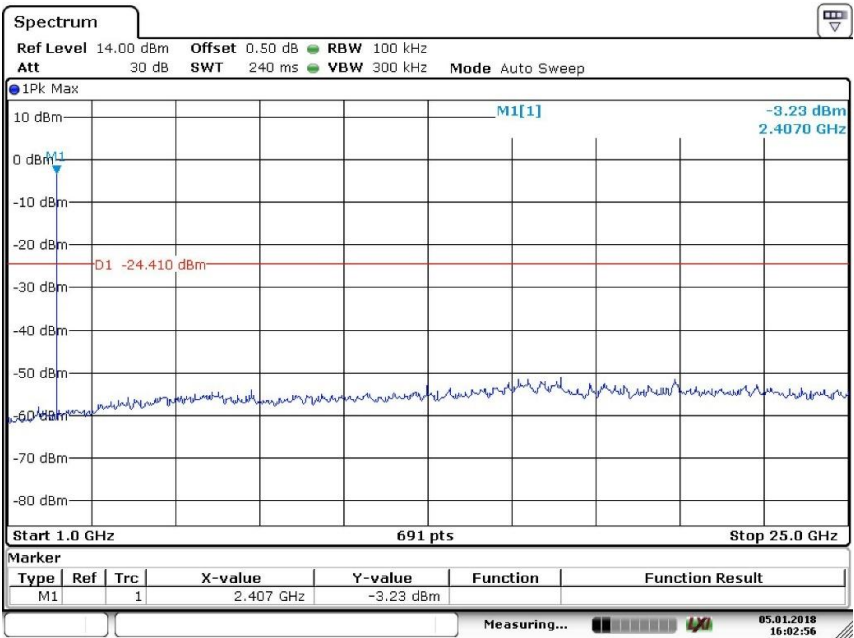


Spurious RF conducted emissions

2405MHz



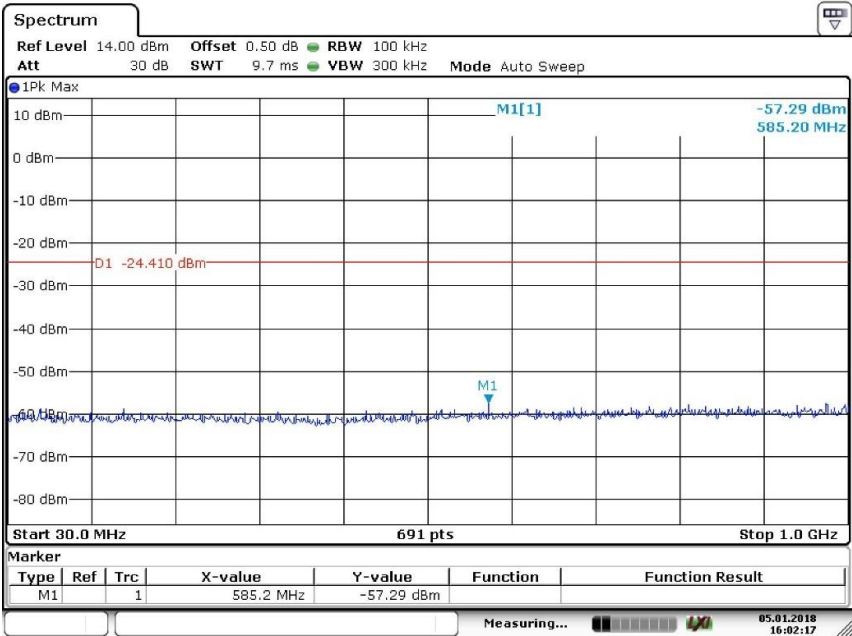
Date: 5.JAN.2018 16:03:11



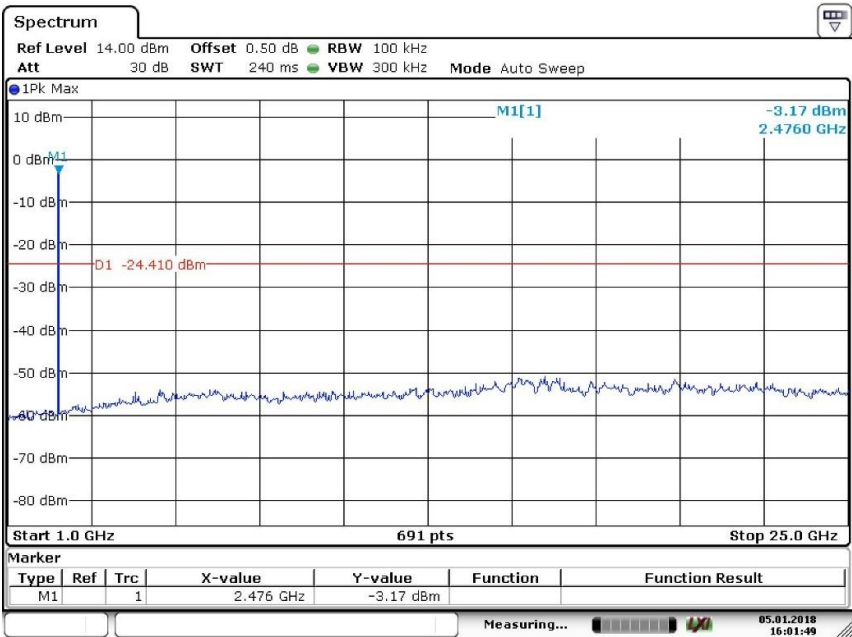
Date: 5.JAN.2018 16:02:57



2445MHz



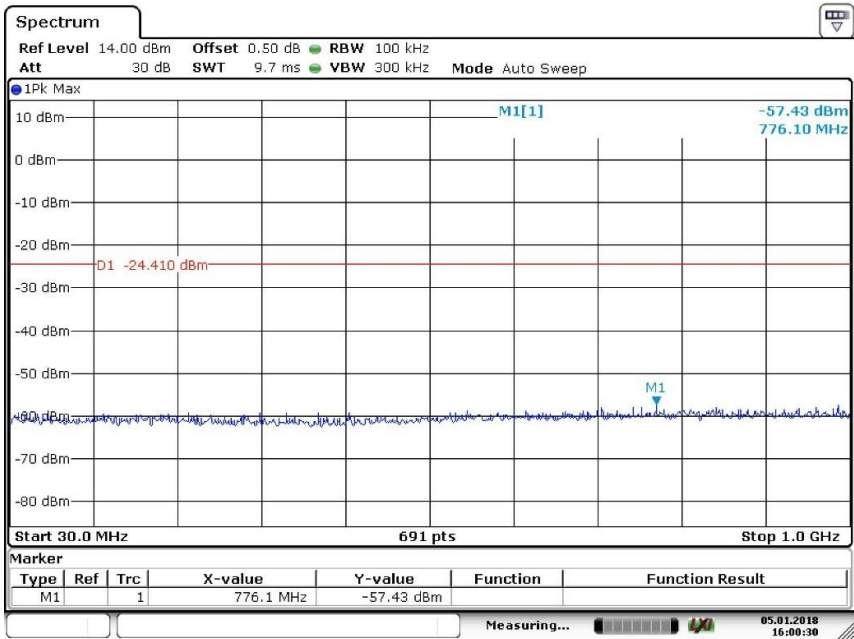
Date: 5.JAN.2018 16:02:17



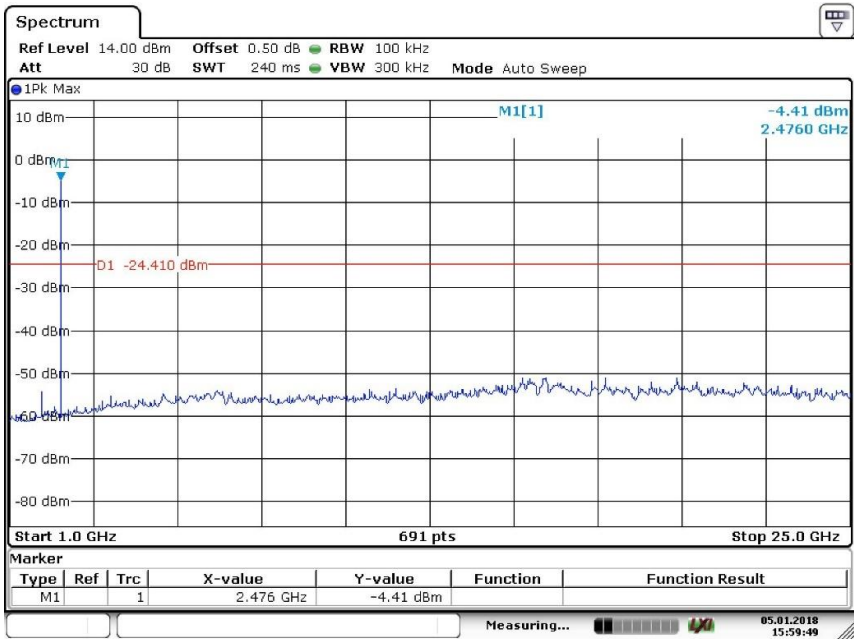
Date: 5.JAN.2018 16:01:50



2480MHz



Date: 5.JAN.2018 16:00:31



Date: 5.JAN.2018 15:59:49

9.5 Band edge

Test Method

- 1 Use the following spectrum analyzer settings:
Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 100 kHz, VBW $\geq$ RBW, Sweep = auto, Detector function = peak, Trace = max hold.
- 2 Allow the trace to stabilize, use the peak and delta measurement to record the result.
- 3 The level displayed must comply with the limit specified in this Section.

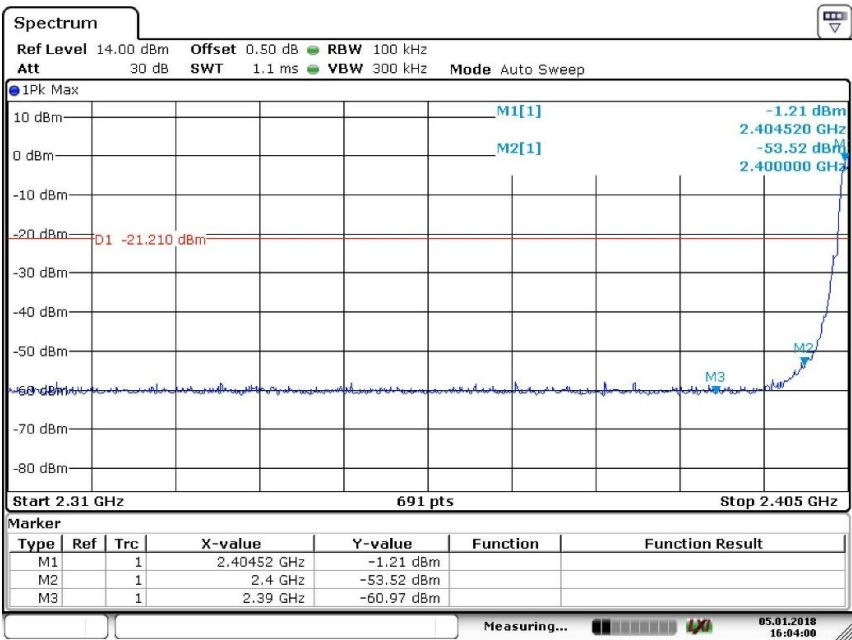
Limit

Frequency Range MHz	Limit (dBc)
30-25000	-20



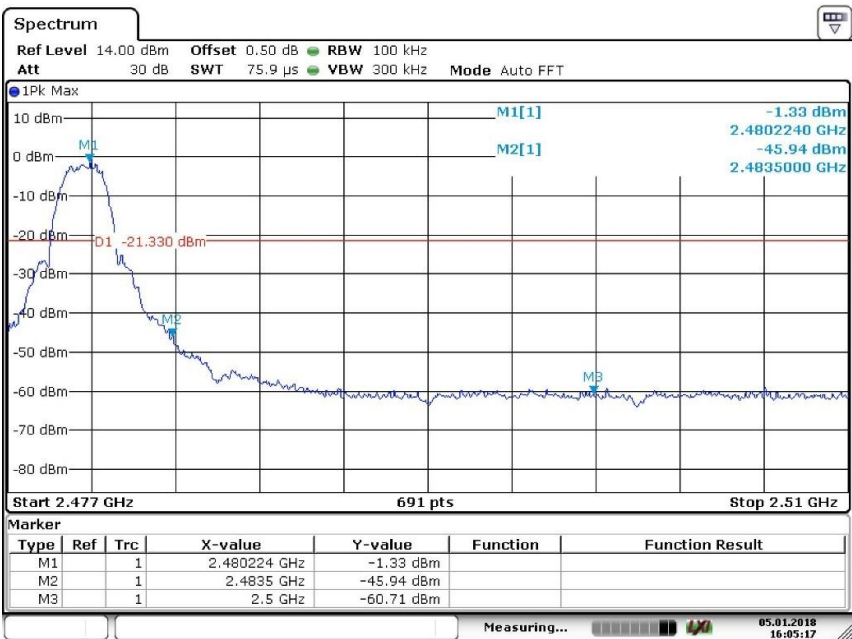
Band edge testing

2405MHz



Date: 5.JAN.2018 16:04:01

2480MHz



Date: 5.JAN.2018 16:05:18

9.6 Spurious radiated emissions for transmitter

Test Method

- 1: The EUT was placed on a turn table which is 1.5m above ground plane for above 1GHz and 0.8m above ground for below 1GHz at 3 meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
- 2: The EUT was set 3 meters away from the interference – receiving antenna, which was mounted on the top of a variable – height antenna tower.
- 3: The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- 4: For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- 5: Use the following spectrum analyzer settings According to C63.10:

For Above 1GHz

Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 1MHz, VBW ≥ RBW for peak measurement and VBW = 10Hz for average measurement, Sweep = auto, Detector function = peak, Trace = max hold.

For Below 1GHz

Use the following spectrum analyzer settings:

Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 100 KHz, VBW ≥ RBW for peak measurement, Sweep = auto, Detector function = peak, Trace = max hold.

Note:

- 1: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120 KHz for Quasi-peak detection (QP) at frequency below 1GHz.
- 2: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 3MHz for peak detection (PK) at frequency above 1GHz.
- 3: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 3MHz for RMS Average ((duty cycle < 98%) for Average detection (AV) at frequency above 1GHz, then the measurement results was added to a correction factor (20log(1/duty cycle)).
- 4: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 10Hz (duty cycle > 98%) for Average detection (AV) at frequency above 1GHz.

Limit

The radio emission outside the operating frequency band shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power. Radiated emissions which fall in the restricted bands, as defined in section 15.205, must comply with the radiated emission limits specified in section 15.209.

Frequency MHz	Field Strength uV/m	Field Strength dBµV/m	Detector
30-88	100	40	QP
88-216	150	43.5	QP
216-960	200	46	QP
960-1000	500	54	QP
Above 1000	500	54	AV
Above 1000	5000	74	PK

Spurious radiated emissions for transmitter

According to C63.10, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement, so AV emission value did not show in below table if the peak value complies with average limit.

Transmitting spurious emission test result as below:

Low channel 2405MHz Test Result

Frequency Band	Frequency	Emission Level	Polarization	Limit	Detector	Margin	Correct factor	Result
	MHz	dBuV/m		dBμV/m		dBuV/m	(dB/m)	
30-1000MHz	650.37	32.04	H	46	QP	13.96	-18.6	Pass
	52.36	19.81	V	40	QP	20.19	-25.6	Pass
1000-25000MHz	4810	42.80	H	74	PK	31.20	0.2	Pass
	--	--	H	54	AV	--	--	Pass
	12475.78	43.03	V	74	PK	30.97	12.8	Pass
	--	--	V	54	AV	--	--	Pass

Middle channel 2445MHz Test Result

Frequency Band	Frequency	Emission Level	Polarization	Limit	Detector	Margin	Correct factor	Result
	MHz	dBuV/m		dBμV/m		dBuV/m	(dB/m)	
30-1000MHz	--	--	H	43.5	QP	--	--	Pass
	--	--	H	46	QP	--	--	Pass
1000-25000MHz	10726.88	41.34	H	74	PK	32.66	10.1	Pass
	--	--	H	54	AV	--	--	Pass
	6000	41.37	V	74	PK	32.63	3.8	Pass
	--	--	V	54	AV	--	--	Pass

High channel 2480MHz Test Result

Frequency Band	Frequency	Emission Level	Polarization	Limit	Detector	Margin	Correct factor	Result
	MHz	dBuV/m		dBuV/m		dBuV/m	(dB/m)	
30-1000MHz	--	--	H	43.5	QP	--	--	Pass
	--	--	H	46	QP	--	--	Pass
1000-25000MHz	8479.69	39.92	H	74	PK	34.08	8.8	Pass
	--	--	H	54	AV	--	--	Pass
	11866.88	42.46	V	74	PK	31.54	12.2	Pass
	--	--	V	54	AV	--	--	Pass

Remark:

- (1) “*” means the emission(s) appear within the restrict bands shall follow the requirement of section 15.205.
- (2) Data of measurement within this frequency range shown “--” in the table above means the reading of emissions are the noise floor or attenuated more than 10dB below the permissible limits or the field strength is too small to be measured.
- (3) Above 1GHz: Corrector factor = Antenna Factor + Cable Loss- Amplifier Gain
Below 1GHz: Corrector factor = Antenna Factor + Cable Loss

10 Test Equipment List

List of Test Instruments

	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE
C	Signal Generator	Rohde & Schwarz	SMB100A	108272	2018-7-7
	Signal Analyzer	Rohde & Schwarz	FSV40	101030	2018-7-7
	Vector Signal Generator	Rohde & Schwarz	SMU 200A	105324	2018-7-7
	RF Switch Module	Rohde & Schwarz	OSP120/OS P-B157	101226/100851	2018-7-7
RE	EMI Test Receiver	Rohde & Schwarz	ESR 26	101269	2018-7-14
	Trilog Super Broadband Test Antenna	Schwarzbeck	VULB 9163	707	2018-7-14
	Horn Antenna	Rohde & Schwarz	HF907	102294	2018-7-14
	Pre-amplifier	Rohde & Schwarz	SCU 18	102230	2018-7-14
	3m Semi-anechoic chamber	TDK	9X6X6	----	2020-7-7

- Conducted peak output power
- 6dB bandwidth and 99% Occupied Bandwidth
- Power spectral density*
- Spurious RF conducted emissions
- Band edge

11 System Measurement Uncertainty

For a 95% confidence level, the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 were:

System Measurement Uncertainty	
Items	Extended Uncertainty
Uncertainty for Radiated Emission in 3m chamber 30MHz-1000MHz	Horizontal: 4.99dB; Vertical: 4.97dB;
Uncertainty for Radiated Emission in 3m chamber 1000MHz-18000MHz	Horizontal: 4.96dB; Vertical: 4.95dB;
Uncertainty for Conducted RF test with TS 8997	Power level test involved: 1.05dB Frequency test involved: 1.16×10^{-7}